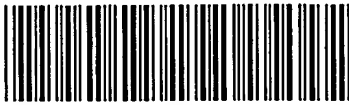


Search Notes

Application/Control No.

10/018,312

Examiner

Jacob Meek

Applicant(s)/Patent under
Reexamination

MICHEL ET AL.

Art Unit

2637

SEARCHED

Class	Subclass	Date	Examiner
375	130,140 320,335 208,344 145	7/18/2005	JM
708	250	7/18/2005	JM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	140	7/18/2005	JM
375	354	7/18/2005	JM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NPL	7/18/2005	JM
East	7/18/2005	JM